## CLAIMS

1.	A	method	of	production	of	a	dielectric	ceramic
compositio	n	having	at	least				

a main component expressed by a formula  $Ba_mTiO_{2+n}$ , wherein m is  $0.995 \le m \le 1.010$ , n is  $0.995 \le n \le 1.010$ , and the ratio of Ba and Ti is  $0.995 \le Ba/Ti \le 1.010$ ,

a first subcomponent containing at least one compound selected from MgO, CaO, BaO, SrO, and  $Cr_2O_3$ ,

a second subcomponent containing at least one compound selected from  ${\rm SiO}_2$ , MO (where M is at least one element selected from Ba, Ca, Sr, and Mg),  ${\rm Li}_2{\rm O}$ , and  ${\rm B}_2{\rm O}_3$ ,

a third subcomponent containing at least one compound selected from  $V_2O_5$ ,  $MoO_3$ , and  $WO_3$ , and

a fourth subcomponent containing an oxide of R (where R is at least one element selected from Y, Dy, Td,  $\operatorname{Gd}$ , and  $\operatorname{Ho}$ ), wherein

 $$\operatorname{\textsc{the}}$  ratio of the subcomponents with respect to 100 moles of the main component is

first subcomponent: 0.1 to 3 moles, second subcomponent: 2 to 12 moles, third subcomponent: 0.01 to 3 moles,

fourth subcomponent: 0.1 to 10.0 moles (where, the number of moles of the fourth subcomponent is a ratio of R  $_{\rm alone)}$  ,

said method of producing the dielectric ceramic
composition comprising the step of:

mixing in said main component at least part of other subcomponents except for said second subcomponent to prepare a pre-calcination powder,

calcining the pre-calcination powder to prepare a calcined powder, and

mixing at least said second subcomponent in said calcined powder to obtain the dielectric ceramic composition having molar ratios of the subcomponents to the main

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component of the above ratios.

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- 2. The method of production of a dielectric ceramic composition as set forth in claim 1, obtaining a dielectric ceramic composition further containing a fifth subcomponent containing MnO and having a ratio of the fifth subcomponent to 100 moles of the main component of 0.05 to 1.0 mole.
- 3. The method of production of a dielectric ceramic composition as set forth in claim 1, obtaining a dielectric ceramic composition having a molar ratio of the third subcomponent to 100 moles of the main component of 0.01 to 0.1 mole.
- 4. The method of production of a dielectric ceramic composition as set forth in claim 2, obtaining a dielectric ceramic composition having a molar ratio of the third subcomponent to 100 moles of the main component of 0.01 to 0.1 mole.
- 5. The method of production of a dielectric ceramic composition as set forth in claim 1, wherein the precalcination powder is prepared so that the molar ratios of components contained in the pre-calcination powder (Ba+metal element of the first subcomponent)/(Ti+metal element of the fourth subcomponent) is less than 1, or (Ba+metal element of the fourth subcomponent)/(Ti+metal element of the first subcomponent) is over 1, and calcination is performed.
- 6. The method of production of a dielectric ceramic composition as set forth in claim 2, wherein the precalcination powder is prepared so that the molar ratios of components contained in the pre-calcination powder (Ba+metal element of the first subcomponent)/(Ti+metal element of the fourth subcomponent) is less than 1, or (Ba+metal element of the fourth subcomponent)/(Ti+metal element of the first subcomponent) is over 1, and calcination is performed.
  - 7. The method of production of a dielectric ceramic composition as set forth in claim 1, wherein the first subcomponent is always contained in the pre-calcination

powder when preparing the pre-calcination powder.

- 8. The method of production of a dielectric ceramic composition as set forth in claim 2, wherein the first subcomponent is always contained in the pre-calcination powder when preparing the pre-calcination powder.
- 9. The method of production of a dielectric ceramic composition as set forth in claim 1, wherein the precalcination powder is calcined at a temperature of 500°C to less than 1200°C.
- 10. The method of production of a dielectric ceramic composition as set forth in claim 2, wherein the precalcination powder is calcined at a temperature of 500°C to less than 1200°C.
  - 11. The method of production of a dielectric ceramic composition as set forth in claim 9, wherein the calcination is performed for a plurality of times.
  - 12. The method of production of a dielectric ceramic composition as set forth in claim 10, wherein the calcination is performed for a plurality of times.
  - 13. The method of production of a dielectric ceramic composition as set forth in claim 1, wherein a mean particle size of the main component is 0.1 to 0.7  $\mu m$ .
  - 14. The method of production of a dielectric ceramic composition as set forth in claim 2, wherein a mean particle size of the main component is 0.1 to 0.7  $\mu m$ .
  - 15. The method of production of a dielectric ceramic composition as set forth in claim 1, wherein at least 70 wt% of the calcined powder is used with respect to the entire dielectric material as 100 wt%.
- 16. The method of production of a dielectric ceramic composition as set forth in claim 2, wherein at least 70 wt% of the calcined powder is used with respect to the entire dielectric material as 100 wt%.
- 17. A method of production of an electronic device containing dielectric layers comprising forming dielectric

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layers by using the dielectric ceramic composition obtained by the method set forth in claim 1.

18. A method of production of an electronic device containing dielectric layers comprising forming dielectric layers by using the dielectric ceramic composition obtained by the method set forth in claim 2.

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19. A method of production of a multilayer ceramic capacitor comprised by alternately stacking interal electrodes comprised of Ni or Ni alloy and dielectric layers, where each of dielectric layers contains, in the molar ratios indicated, BaTiO $_3$ : 100 moles, at least one of MgO and CaO: 0.1 to 3 moles, MnO: 0.05 to 1.0 mole,  $Y_2O_3$ : 0.1 to 5 moles,  $V_2O_5$ : 0.01 to 3 moles, and Ba $_aCa_{1-a}SiO_3$  (where the symbol (a) is a number from 0 to 1): 2 to 12 moles,

characterized by using at least 70 wt% of the material, which is premixed in BaTiO<sub>3</sub> at least one of MgO, CaO and a compound forming MgO or CaO upon heat treatment, and precalcined at a temperature of 900°C to 1300°C, with respect to the entire dielectric material.

20. A method of production of a multilayer ceramic capacitor comprised by alternately stacking interal electrodes comprised of Ni or Ni alloy and dielectric layers, where each of dielectric layers contains, in the molar ratios indicated, BaTiO $_3$ : 100 moles, at least one of MgO and CaO: 0.1 to 3 moles, MnO: 0.05 to 1.0 mole,  $Y_2O_3$ : 0.1 to 5 moles,  $V_2O_5$ : 0.01 to 3 moles, and Ba $_a$ Ca $_{1-a}$ SiO $_3$  (where the symbol (a) is a number from 0 to 1): 2 to 12 moles,

characterized by using at least 70 wt% of the material, which is premixed in  $BaTiO_3$  at least one of MgO, CaO and a compound forming MgO or CaO upon heat treatment, MnO or a compound forming MnO upon heat treatment,  $Y_2O_3$  or a compound forming  $Y_2O_3$  upon heat treatment, and  $Y_2O_5$  or a compound forming  $Y_2O_5$  upon heat treatment, and pre-calcined at a temperature of 900°C to 1300°C, with respect to the entire dielectric material.

- 21. The method of production of a multilayer ceramic capacitor as set forth in claim 19, wherein a mean particle size of the main component is 0.2 to 0.7  $\mu \rm m$ .
- 22. The method of production of a multilayer ceramic capacitor as set forth in claim 20, wherein a mean particle size of the main component is 0.2 to 0.7  $\mu m$ .